

MOSFET

OptiMOS™ 8 Power-Transistor, 100 V

Features

- N-channel, normal level
- Very low on-resistance $R_{DS(on)}$
- High I_D current rating
- Tight $V_{GS(th)}$ spread
- Soft body diode recovery and low Q_{rr}
- 100% avalanche tested
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21
- MSL 1 classified according to J-STD-020

Product validation

Qualified according to relevant JEDEC tests.

Table 1 Key performance parameters

Parameter	Value	Unit
V_{DS}	100	V
$R_{DS(on),max}$	1.34	mΩ
I_D	179	A
Q_{oss}	499	nC
Q_G (0 V...10 V)	255	nC
Q_{rr} (100 A/μs)	116	nC

Part number	Package	Marking	Related links
IPB013N10NM8	PG-TO263-3	013N10N8	-

D²PAK

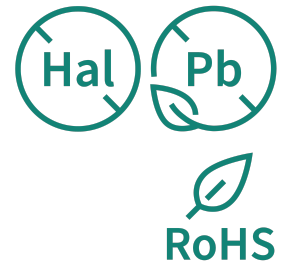
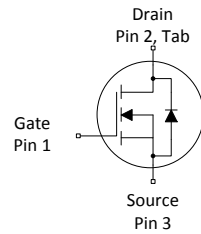
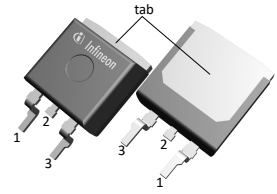




Table of contents

Description	1
Maximum ratings	3
Thermal characteristics	4
Electrical characteristics	5
Electrical characteristics diagrams	7
Package outlines	12
Revision history	13
Trademarks	14
Disclaimer	14

1 Maximum ratings

at $T_A=25\text{ °C}$, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Continuous drain current ¹⁾	I_D	-	-	179	A	$V_{GS}=10\text{ V}, T_C=25\text{ °C}$
				139		$V_{GS}=10\text{ V}, T_C=100\text{ °C}$
				139		$V_{GS}=15\text{ V}, T_C=100\text{ °C}$
				37		$V_{GS}=10\text{ V}, T_A=25\text{ °C}, R_{THJA}=40\text{ °C/W}^2)$
Pulsed drain current ³⁾	$I_{D,pulse}$	-	-	716	A	$T_A=25\text{ °C}$
Avalanche energy, single pulse ⁴⁾	E_{AS}	-	-	1170	mJ	$I_D=100\text{ A}, R_{GS}=25\text{ }\Omega$
Gate source voltage	V_{GS}	-20	-	20	V	-
Power dissipation	P_{tot}	-	-	500	W	$T_C=25\text{ °C}$
				3.8		$T_A=25\text{ °C}, R_{THJA}=40\text{ °C/W}^2)$
Operating and storage temperature	T_j, T_{stg}	-55	-	175	°C	IEC climatic category; DIN IEC 68-1: 55/175/56

¹⁾ Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature at 25°C. For higher case temperature please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

³⁾ See Diagram 3 for more detailed information

⁴⁾ See Diagram 14 for more detailed information

2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	R_{thJC}		0.2	0.3	°C/W	-
Thermal resistance, junction - ambient, 6 cm ² cooling area ⁵⁾	R_{thJA}	-	-	40		
Thermal resistance, junction - ambient, minimal footprint	R_{thJA}	-	-	62		

⁵⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

3 Electrical characteristics

at $T_j=25\text{ °C}$, unless otherwise specified

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	100	-	-	V	$V_{GS}=0\text{ V}$, $I_D=1\text{ mA}$
Gate threshold voltage	$V_{GS(th)}$	2.4	2.8	3.2	V	$V_{DS}=V_{GS}$, $I_D=279\text{ }\mu\text{A}$
Zero gate voltage drain current	I_{DSS}	-	0.1	1	μA	$V_{DS}=80\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ °C}$
Zero gate voltage drain current ⁶⁾	I_{DSS}	-	10	100	μA	$V_{DS}=80\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=125\text{ °C}$
Gate-source leakage current	I_{GSS}	-	10	100	nA	$V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	1.18	1.34	m Ω	$V_{GS}=15\text{ V}$, $I_D=100\text{ A}$
			1.22	1.38		$V_{GS}=10\text{ V}$, $I_D=100\text{ A}$
			1.28	1.44		$V_{GS}=8\text{ V}$, $I_D=50\text{ A}$
Gate resistance ⁶⁾	R_G	-	1.1	2.3	Ω	-
Transconductance ⁶⁾	g_{fs}	140	280	-	S	$ V_{DS} \geq 2 I_D $, $R_{DS(on)max}$, $I_D=100\text{ A}$

⁶⁾ Defined by design. Not subject to production test.

Table 5 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Input capacitance ⁷⁾	C_{iss}	-	16000	21000	pF	$V_{GS}=0\text{ V}$, $V_{DS}=50\text{ V}$, $f=1\text{ MHz}$
Output capacitance ⁷⁾	C_{oss}		2400	3100		
Reverse transfer capacitance ⁷⁾	C_{rss}		450	790		
Turn-on delay time	$t_{d(on)}$	-	31	-	ns	$V_{DD}=50\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=50\text{ A}$, $R_{G,ext}=1.6\text{ }\Omega$
Rise time	t_r		31			
Turn-off delay time	$t_{d(off)}$		103			
Fall time	t_f		41			

⁷⁾ Defined by design. Not subject to production test.

Table 6 Gate charge characteristics ⁸⁾

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{gs}	-	69	-	nC	$V_{DD}=50\text{ V}$, $I_D=50\text{ A}$, $V_{GS}=0\text{ to }10\text{ V}$
Gate charge at threshold	$Q_{g(th)}$	-	46	-	nC	
Gate to drain charge ⁹⁾	Q_{gd}	-	62	93	nC	
Switching charge	Q_{sw}	-	85	-	nC	
Gate charge total ⁹⁾	Q_g	-	255	319	nC	
Gate plateau voltage	$V_{plateau}$	-	4.2	-	V	
Gate charge total, sync. FET	$Q_{g(sync)}$	-	213	-	nC	$V_{DS}=0.1\text{ V}$, $V_{GS}=0\text{ to }10\text{ V}$
Output charge ⁹⁾	Q_{oss}	-	499	664	nC	$V_{DS}=50\text{ V}$, $V_{GS}=0\text{ V}$

⁸⁾ See "Gate charge waveforms" for parameter definition

⁹⁾ Defined by design. Not subject to production test.

Table 7 Reverse diode

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Diode continuous forward current	I_S	-	-	160	A	$T_C=25\text{ °C}$
Diode pulse current	$I_{S,pulse}$	-	-	716		
Diode forward voltage	V_{SD}	-	0.86	1	V	$V_{GS}=0\text{ V}$, $I_F=100\text{ A}$, $T_J=25\text{ °C}$
Reverse recovery time ¹⁰⁾	t_{rr}	-	54	108	ns	$V_R=50\text{ V}$, $I_F=50\text{ A}$, $di_F/dt=100\text{ A}/\mu\text{s}$
Reverse recovery charge ¹⁰⁾	Q_{rr}	-	116	232	nC	
Reverse recovery time ¹⁰⁾	t_{rr}	-	53	106	ns	$V_R=50\text{ V}$, $I_F=50\text{ A}$, $di_F/dt=1000\text{ A}/\mu\text{s}$
Reverse recovery charge ¹⁰⁾	Q_{rr}	-	908	1816	nC	

¹⁰⁾ Defined by design. Not subject to production test.

4 Electrical characteristics diagrams

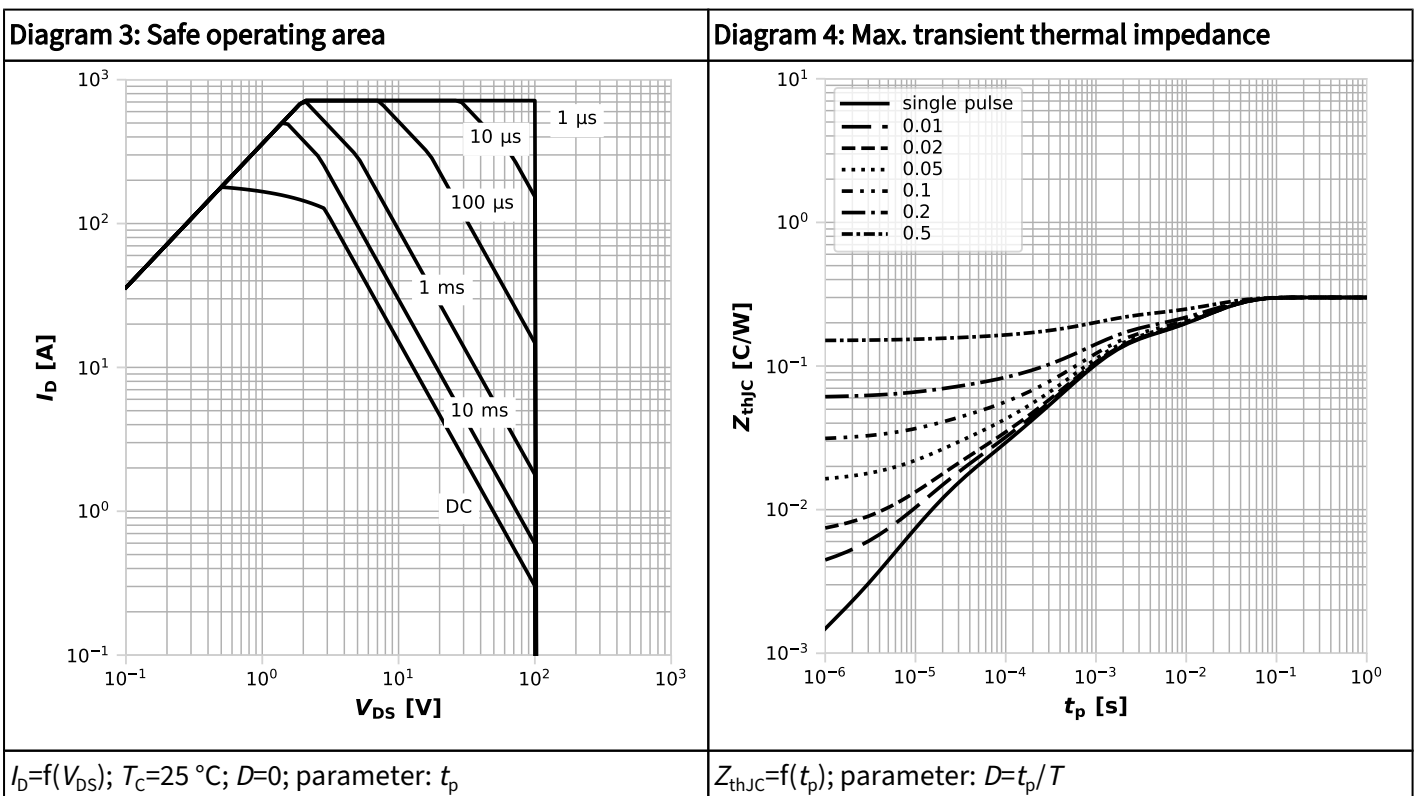
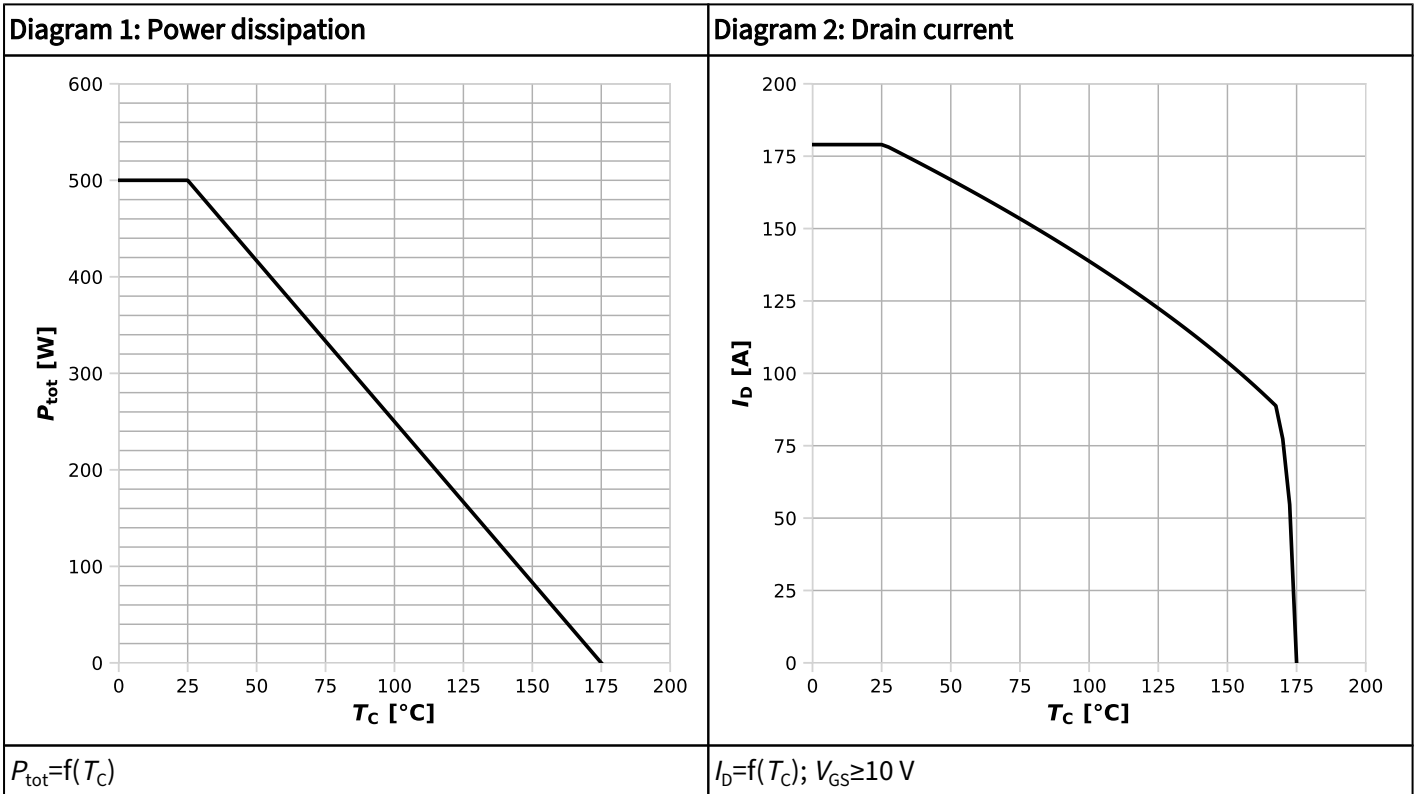
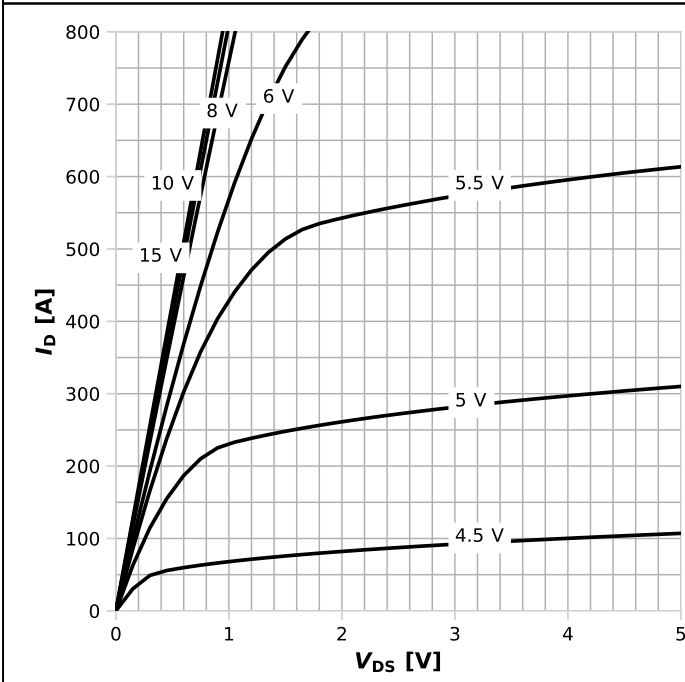
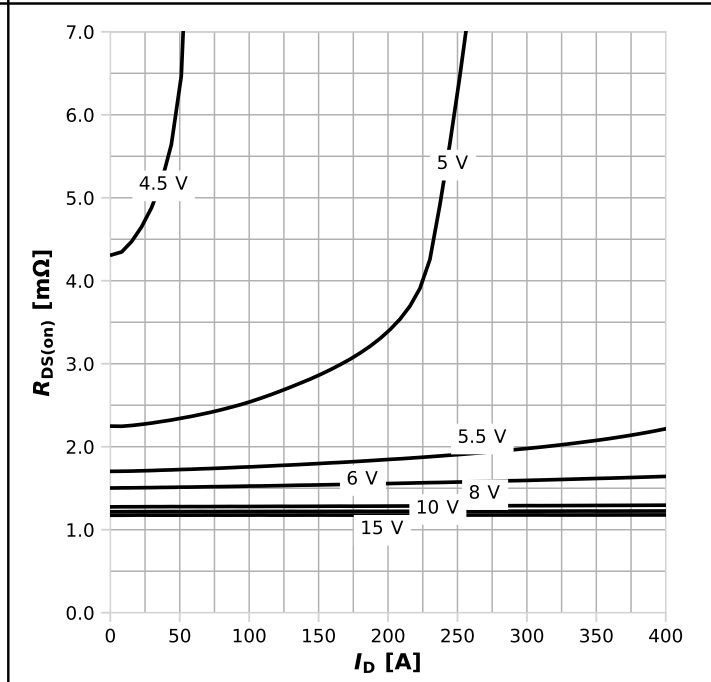


Diagram 5: Typ. output characteristics



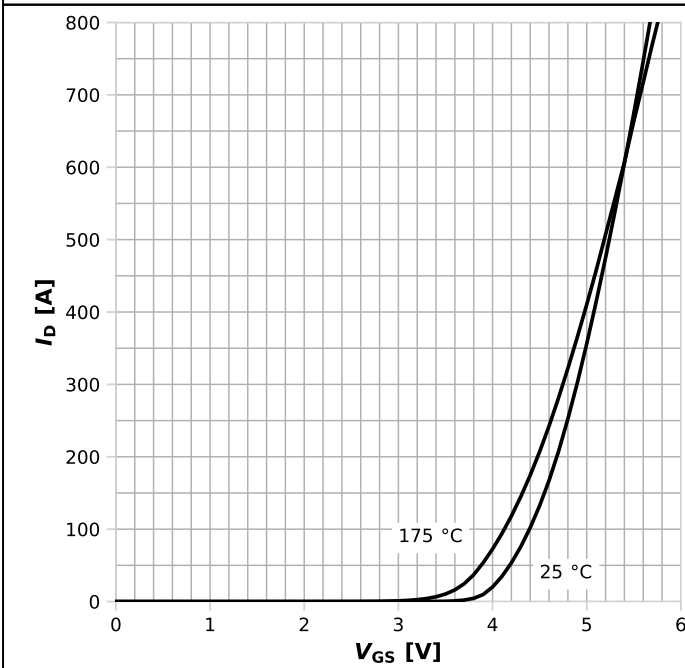
$I_D = f(V_{DS}), T_j = 25\text{ °C};$ parameter: V_{GS}

Diagram 6: Typ. drain-source on resistance



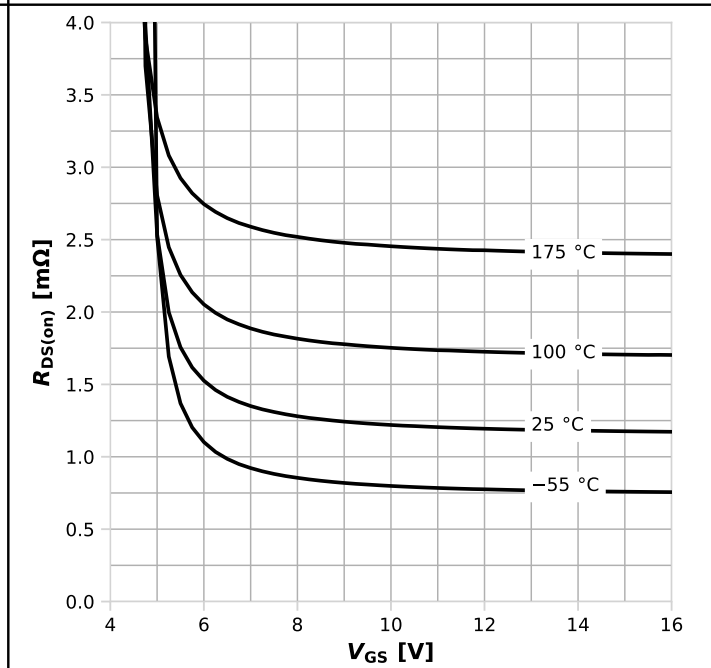
$R_{DS(on)} = f(I_D), T_j = 25\text{ °C};$ parameter: V_{GS}

Diagram 7: Typ. transfer characteristics



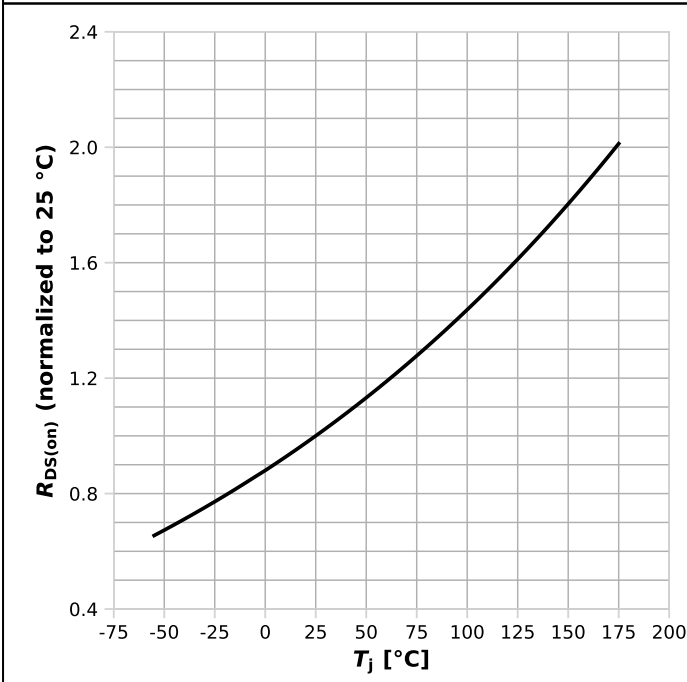
$I_D = f(V_{GS}), |V_{DS}| > 2|I_D|R_{DS(on)max};$ parameter: T_j

Diagram 8: Typ. drain-source on resistance



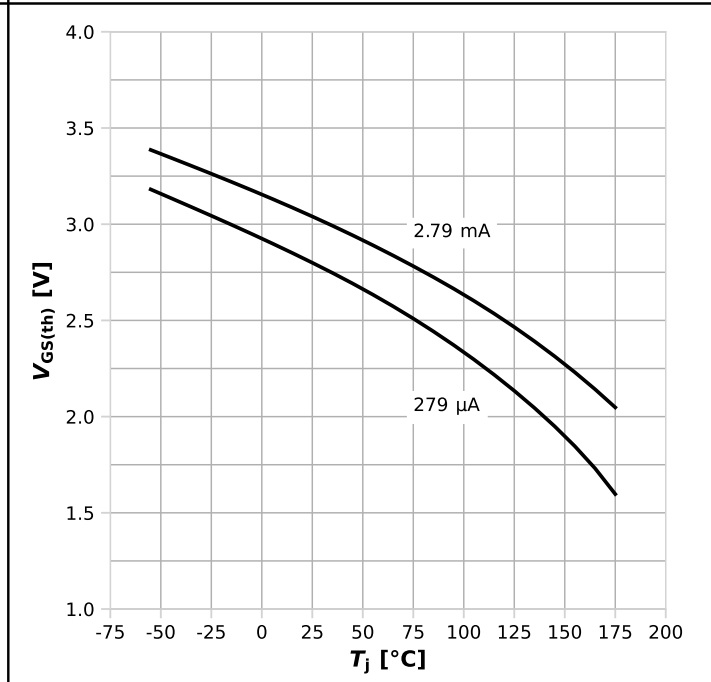
$R_{DS(on)} = f(V_{GS}), I_D = 100\text{ A};$ parameter: T_j

Diagram 9: Normalized drain-source on resistance



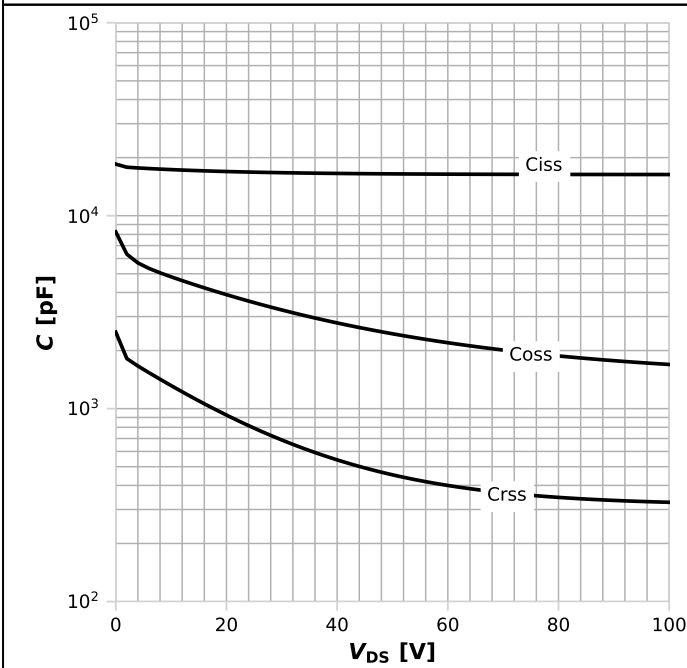
$R_{DS(on)}=f(T_j), I_D=100\text{ A}, V_{GS}=10\text{ V}$

Diagram 10: Typ. gate threshold voltage



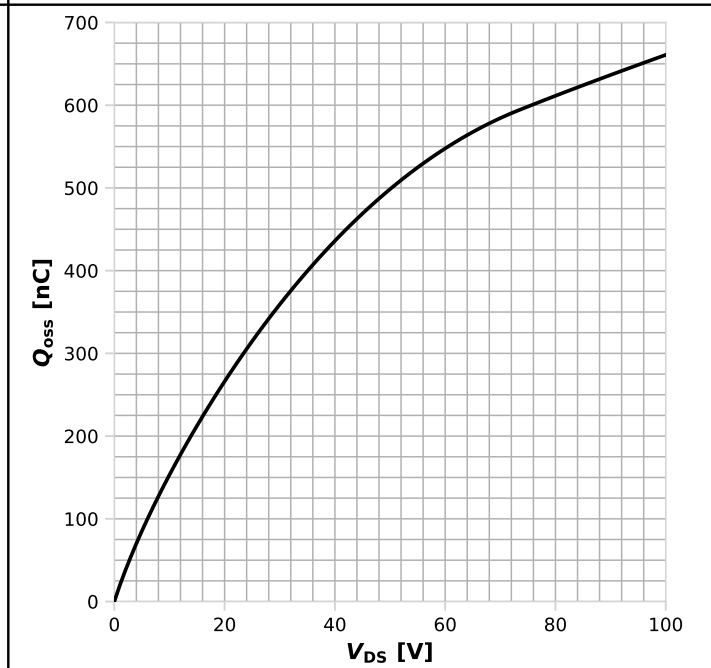
$V_{GS(th)}=f(T_j), V_{GS}=V_{DS};$ parameter: I_D

Diagram 11: Typ. capacitances



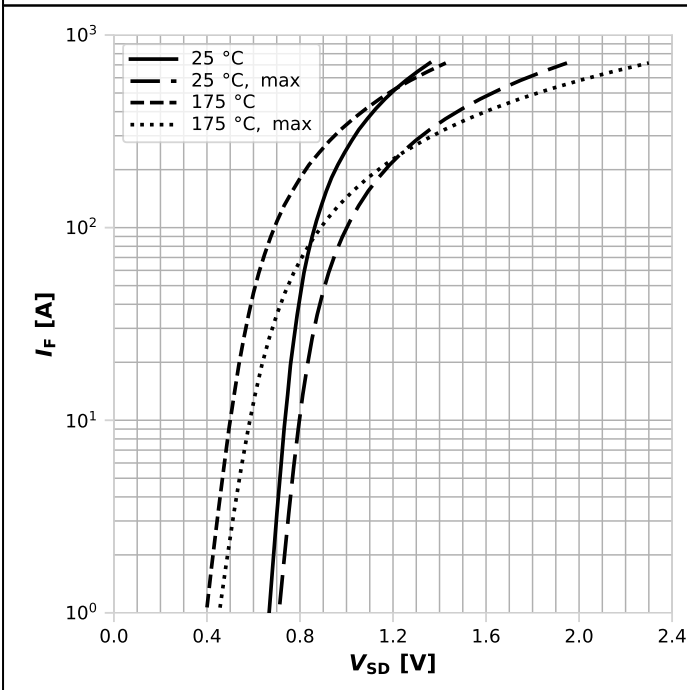
$C=f(V_{DS}); V_{GS}=0\text{ V}; f=1\text{ MHz}$

Diagram 12: Typ. output charge



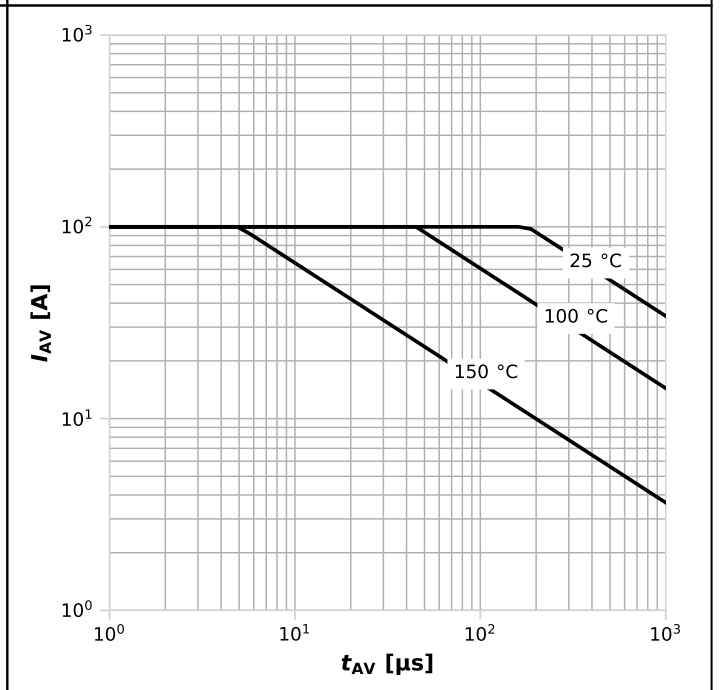
$Q_{oss}=f(V_{DS}), V_{GS}=0\text{ V}$

Diagram 13: Forward characteristics of reverse diode



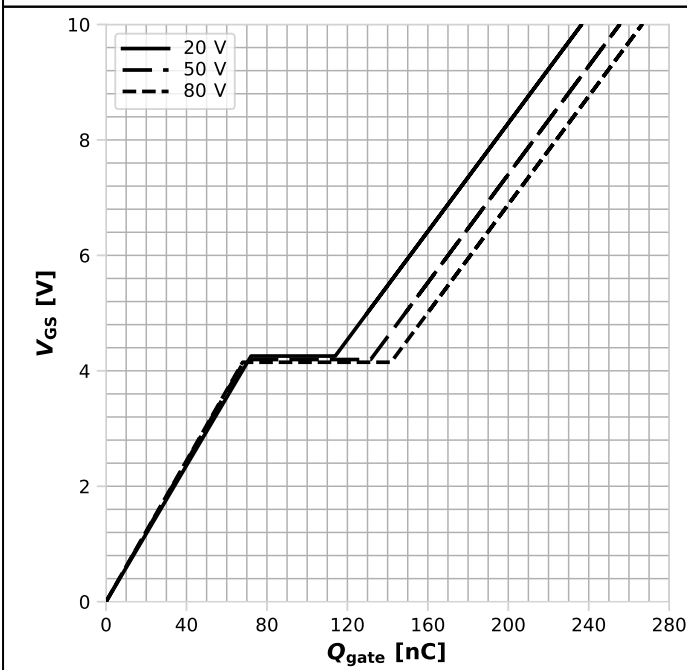
$I_F = f(V_{SD})$; parameter: T_j

Diagram 14: Avalanche characteristics



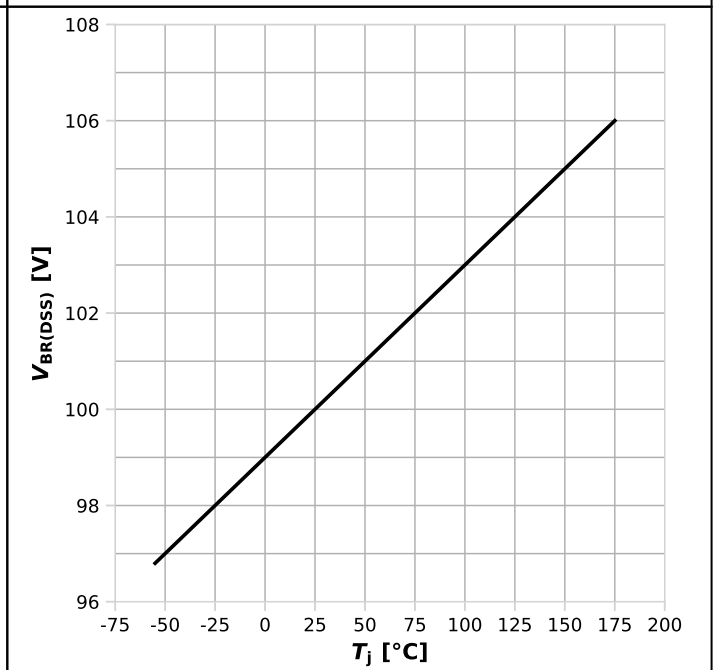
$I_{AS} = f(t_{AV})$; $R_{GS} = 25 \Omega$; parameter: $T_{j,start}$

Diagram 15: Typ. gate charge

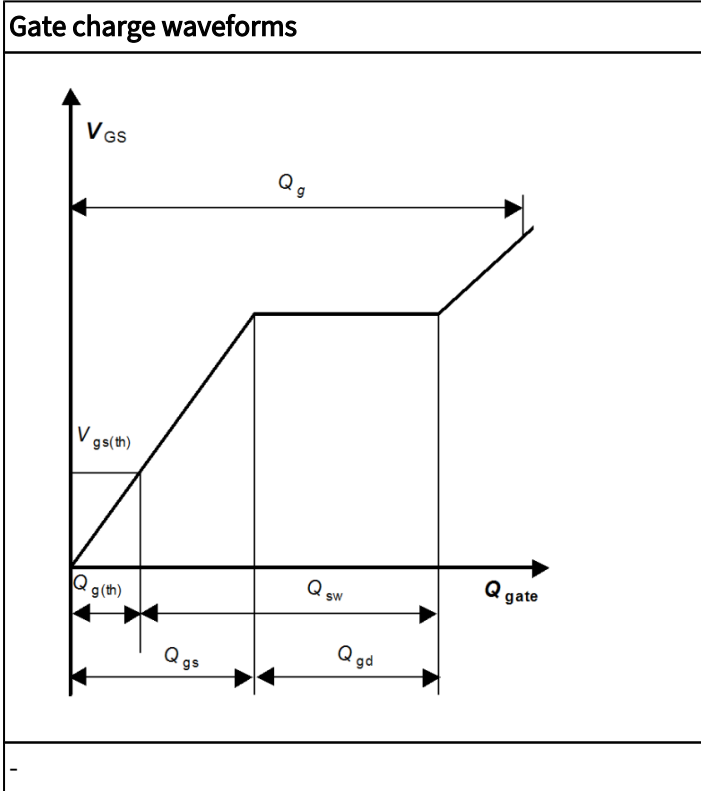


$V_{GS} = f(Q_{gate})$, $I_D = 50 \text{ A pulsed}$, $T_j = 25 \text{ °C}$; parameter: V_{DD}

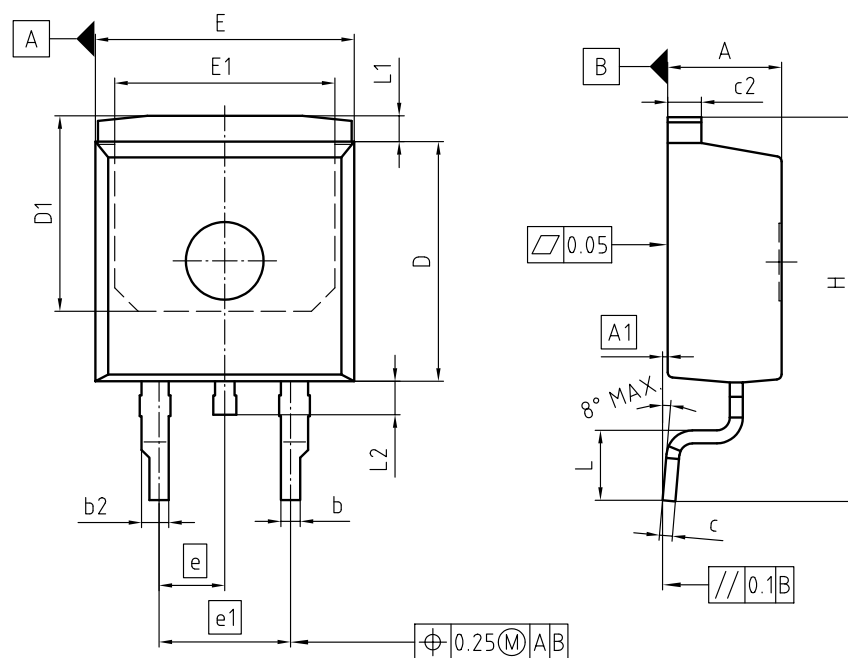
Diagram 16: Min. drain-source breakdown voltage



$V_{BR(DSS)} = f(T_j)$; $I_D = 1 \text{ mA}$



5 Package outlines



PACKAGE - GROUP NUMBER: PG-TO263-3-U01		
DIMENSIONS	MILLIMETERS	
	MIN.	MAX.
A	4.30	4.50
A1	0.00	0.10
b	0.65	0.85
b2	0.95	1.15
c	0.40	0.60
c2	1.17	1.37
D	9.05	9.45
D1	7.45	7.65
E	9.80	10.20
E1	8.40	8.60
e	2.54	
e1	5.08	
N	2	
H	14.60	15.90
L	2.40	3.00
L1	0.70	1.30
L2	1.00	1.60

Figure 1 Outline PG-TO263-3, dimensions in mm



Revision history

IPB013N10NM8

Revision 2025-12-10, Rev. 1.0

Previous revisions

Revision	Date	Subjects (major changes since last revision)
1.0	2025-12-10	Release of final version

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